


<b>Search Notes</b>  	<b>Application/Control No.</b>  10016332	<b>Applicant(s)/Patent Under Reexamination</b>  SAKO ET AL.
	<b>Examiner</b>  HUY T NGUYEN	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST INTERFERENCE SEARCH. SEE PRINTOUT	6/10/2008	HN

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